

Search Notes

Application/Control No.

10/067,384

Examiner

Jacob Meek

Applicant(s)/Patent under
Reexamination

TAKEUCHI, ISAO

Art Unit

2637

SEARCHED

Class	Subclass	Date	Examiner
375	146,141 130,229 343,225 281	7/22/2005	JM
370	332	7/22/2005	JM
455	13.4,38.3	7/22/2005	JM
455	67.3,69	7/22/2005	JM
455	226.3	7/22/2005	JM
375	284	7/22/2005	JM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	7/22/2005	JM
NPL	7/22/2005	JM